

## **Deep-UV probing method detects electron transfer in photovoltaics**

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Sensitized solar cells consisting of a molecular or solid-state sensitizer that serves to collect light and inject an electron into a substrate that favors their migration are among the most studied photovoltaic systems at present. Despite its importance in determining the potential of a photovoltaic device, current methods for monitoring the interfacial



electron transfer remain ambiguous. Now, using deep-ultraviolet continuum pulses, EPFL scientists have developed a substrate-specific method to detect electron transfer. The work is published in the *Journal of the American Chemical Society*.

The work was carried out by the lab of Majed Chergui at EPFL, which specializes in ultrafast spectroscopy. The group focused on two types of dye-sensitized solar conversion systems: one based on titanium dioxide, the other on zinc-oxide nanoparticles, both of which belong to the category of transition-metal oxide (TMO) substrates. These TMOs are characterized by specific absorption bands, which are fingerprints of the system and are due to neutral electron-hole pairs, called an exciton.

The EPFL team aimed to overcome the limitations of current methods of measuring electron transfer, which all use light in the visible-toterahertz frequencies (wavelengths around 400 – 30000 nm). However, this approach is sensitive to carriers that remain free in the TMO <u>substrate</u>. They are therefore unspecific to the type of substrate and cannot be extended to the new generation of solid-state-sensitized <u>solar</u> <u>cells</u> (such as those using perovskites as sensitizers).

Instead, the researchers at EPFL used deep-ultraviolet (260-380 nm wavelength) continuum pulses to probe the TMO substrates in the region of their excitonic transitions and detect <u>electron transfer</u>, via their response. This opens a route to the study of solid-state sensitized cells, as there is hope that the response of the substrate will be distinguished from that of the sensitizer.

**More information:** Edoardo Baldini et al. Interfacial Electron Injection Probed by a Substrate-Specific Excitonic Signature, *Journal of the American Chemical Society* (2017). DOI: 10.1021/jacs.7b06322



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